

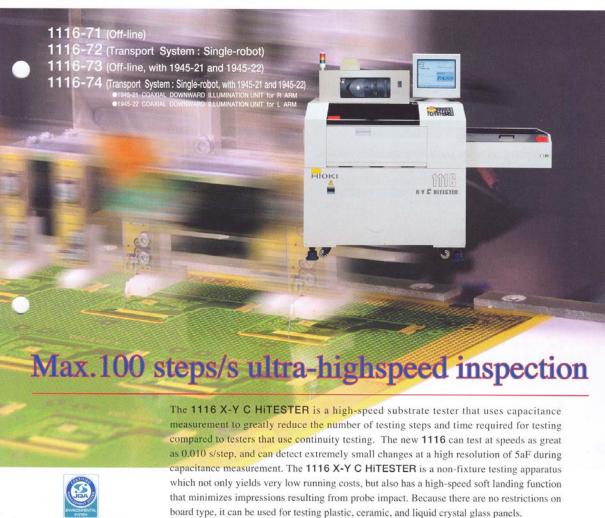
## Two-arm model



## 1116 X-Y C HITESTER

**Automatic Testing Equipment** 









HIOKI company overview, new products, environmental considerations and

## From ordinary bare boards to high-density

## BGA, CSP, or MCM packages Accommodates flexible boards too

## ■ Maximum measurement speed of 0.014 s/step

The 1116 X-Y C HITESTER can test at speeds as great as 0.014 s/step.

(with 0.1 mm movement and all two arms used simultaneously during capacitance measurement)

## ■ Capacitance measurement resolution of 5aF(1aF=10<sup>-6</sup>pF)

Since the variation in capacitance accompanying a fault may be extremely small, high resolution is required for capacitance measurement. With a high resolution of 5aF, the 1116 X-Y C HITESTER can detect extremely small variations.

## ■ High-precision probing

With a minimum pad diameter of just ±20mm, the 1116's high-precision design assures accurate probing of fine pitch pattern pads.

## ■ A standard automatic positioning correction function

Together with a high-precision mechanism, the automatic positioning correction function assures an additional degree of probing accuracy.

## ■ Vacuum clamping

The board being tested are fixed using the vacuum clamping method. Since chucks are not required to secure the board during carrying and testing, all areas on the board can be tested.

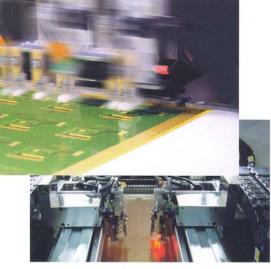
## ■ Large testing area

The 1116 X-Y C HITESTER has a testing area of up to 610 (W)  $\times$  510 (D) mm, allowing the testing of large boards.

## ■ Two keyboard heights

The keyboard can be placed at two heights to accommodate both standing and sitting working postures.



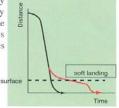


## ■ Minimal probing impact

Probing impact is kept to a minimum with the high-speed soft landing function and shock-absorbing probes.

### High-speed soft landing function

The probes are raised while they are being moved, and are only lowered for testing. To soften the impact, the speed of descent is lessened as the probe approaches the target.



### Accommodates boards as thin as 0.1 mm

Boards with thicknesses ranging from 0.1 mm to 3.2 mm can be tested, making it possible to test thin boards, such as flexible circuit boards.

## ■ A variety of electrical measurements

In addition to capacitance measurement, the 1116 X-Y C HITESTER can also measure resistance, inductance, diode VF, and voltage.

## ■ Loading system is standard outfit

A single axis actuator is used to move the vacuum clamping jig. Boards to be tested can easily be set from outside the main unit.



## High-speed pattern testing using capacitance measurement

Each printed circuit pattern has a particular capacitance, proportional to its area, with respect to the electrically insulated electrode used for testing. If there are circuit breaks, or shorts, then the area of the pattern will differ, and the capacitance will change correspondingly. Therefore, by comparing the capacitance values with those of a reference board, the pattern can be checked for continuity. Since the floating capacitance of the pattern is extremely low, a special-purpose jig with vacuum clamping is used to obtain stable measurement values.

## Testing steps

Using the conductivity measurement method to check pattern A in the figure for continuity requires three steps, measuring 1-2, 1-3, and 1-4, and the same is required for patterns B and C. Checking for short circuits in A, B, and C requires another three steps, testing A-B, A-C, and B-C. Thus, if the circuit is complex, the number of steps is very large. Using the capacitance measurement method, discontinuity and short circuit testing can be achieved by measuring at just the endpoints of each pattern.

## ■ Comparison of testing steps

For 100 networks with all 500 nodes

	Conductivity measurement method	Capacitance measurement method
Discontinuity testing	All nodes in the same network 500 - 100 = 400	Discontinuity and short circuit testing for capacitance measurements of all nodes.
Short circuit testing	nCr = 100C2 100 ×(100-1)/2 = 4950	
Testing steps	5350	500

## Convenient features

Self-diagnostic functions

Statistics functions

Arm offset function

Password protection function

Various test repeat functions

Badmark detect on function

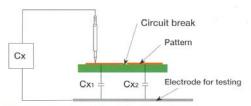
Failure map display function

Continuous FAIL stop

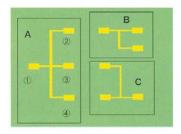
Board thickness correction function

Camera offset function

Same step continuous FAIL stop



When there is no circuit break, Cx = Cx1 + Cx2When there is a circuit break, Cx = Cx1In the case of a circuit break, the capacitance is detected as being lower than that of a reference board; if there is a short circuit, it will be detected as higher.



As shown in the figure below, if there is a discontinuity near one end of the pattern, then there is very little change in the capacitance measured from a, but a large change measured from b.



## Testing data with FLY LINE

FLY LINE searches for network information and end point coordinates from various types of garber and NC data, and automatically extracts the testing points required to conduct pattern tests for printed substrates. FLY LINE produces test data with great efficiency.



Supports unattended operation when used with a handler

### 1116 Specifications

No. of arms	2	
No. of probes	2	
No. of test steps	Max. 40,000 (300,000 for continuous testing)	
Test ranges	DC measurement function Resistance : $400\mu\Omega$ to $40M\Omega$ Capacitance : $4\mu$ F to $400\text{m}\Gamma$ Diodes, transistors (VF) : 0 to 25V Zener diodes (VZ) : 0 to 25V Short circuit : $400\text{m}\Omega$ to $40k\Omega$ Open circuit : $4\Omega$ to $4M\Omega$ Voltage : 0 to 25V AC measurement function Resistance : $100\Omega$ to $100M\Omega$	
Measurement signal	Capacitance :10 fF to $10\mu$ F Coils : $10\mu$ H to $100$ H DC constant voltage : $100$ mV/ $400$ mV(2 ranges) DC constant current : $200$ nA to $200$ mA(13 ranges) AC constant voltage : $1$ V ms/ $10$ V peak (2 ranges) AC frequency : $160$ Hz/ $1.6$ kHz/ $16$ kHz/	
Measurement ranges	DC voltage measurement: 800 µV to 25V fs(8 ranges) DC current measurement: 100nA to 25 mAfs.(7 ranges) AC current measurement: 10µA to 10mAmrs.(4 ranges) for 1 Vms : 100µA/1mA (2 ranges) for 10 Vpcak	
Decision range setting	-99.9% to +999.9% or absolute value	
Measurement time	Min. 0.010 s/step (0.1 mm movement with 2-arm simultaneous probing during capacitance measurement)	
Minimum pad diameter	20µm	
Minimum movement step	XY: 1.00μm/pulse Z: 6.00μm/pulse	
Minimum Probing pitch	50 µm Using a link-type probe. Proper operation is subject to certain conditions.	

Probe work area	610(W)×510(D)mm	
Fixed and movable boards	Thickness: 0.1 to 3.2 mm  External dimensions: 50x50mm to 610x510mm  Component mounting limits:  Upper surface; 12 mm(including board thickness)  Lower surface; not possible  Board weight: 2.0 kg max.	
Board-carrier	Vacuum jig horizontal carrier with a single axis actuator	
Positioning correction	Automatic positioning correction function	
Safety devices	Emergency stop switch, safety cover (of anti-static resin), interference prevention (stops arms from colliding)	
External memory	FDD, HDD, CD-ROM	
Display	17-inch color display	
Power supply	200 V AC±10%(single phase) 50/60Hz Power consumption :3kVA	
Pneumatic system	Primary pressure: 0.5 to 0.99 MPa (dry air)	
Air consumption	Max.0.3Nl/min.	
Operating environment	Temperature : 23±10 °C Humidity : 75%rh or less(no condensation) Atmosphere : Avoid use subject to dust, vibration, or corrosive gases Floor strength: at least 500 kg/m²	
Accessories	Thermal mini printer, printer cable, grease, grease can arm offset board, keyboard, PS/2 mouse, mouse pad mouse pocket, PC accessories, Setup disk, leveling jacks (4), color display (17 inch), power cord (loose ends, 3 m) spare fuse, impression sheets	
Unit dimensions	1465 (W) ×1230 (H)× 1110 (D) mm approx.	
Mass	1000 kg approx.	

## 1116 X-Y C HITESTER

The 1116 does not include a printer, please consult with Hioki regarding availability of English printers.

Pactory options

1355-01 VACUUM PUMP (AC200 V, three phase)

133-20 INSULATION MEASUREMENT UNIT

1941-31 STAMP UNIT for R ARM

1941-32 STAMP UNIT for L ARM

1941-35 STAMP UNIT WITH THE CAP for L ARM

1941-35 STAMP UNIT WITH THE CAP for L ARM

1945-22 COAXIAL DOWNWARD ILLUMINATION UNIT for R ARM

1946-04 MONITOR CAMERA

1947-23 1.2 POWER LENS UNIT for R ARM

1947-24 1.2 POWER LENS UNIT for R ARM

1947-24 1.2 POWER LENS UNIT for L ARM

## Options

Options

1139-03 1116-7x DATA COMPOSITION SOFTWARE

1139-53 FL-Link4 FLY-LINE LINK SOFTWARE

1330-01 MEASUREMENT SECTION CALIBRATION UNIT

1356 MAINTENANCE TOOL SET

1172-66 LINK PROBE (for L and R ARM)

1172-67 DOUBLE LINK PROBE (for L and R ARM)

1172-68 LINK PROBE WITH BLADE (for L and R ARM)

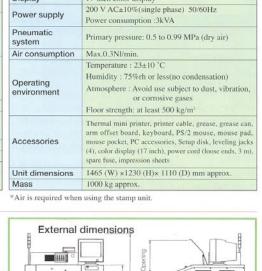
1172-69 DOUBLE LINK PROBE WITH BLADE (for L and R ARM)

1172-70 SHOCK-ABSORBING SINGLE NEEDLE PROBE (SK)

1172-71 SHOCK-ABSORBING SINGLE NEEDLE PROBE (MC)

1172-71 SHOCK-ABSORBING SINGLE NEEDLE PROBE (WC)
1172-72 SHOCK-ABSORBING TRIANGULAR PYRAMID PROBE (SK)

1172-74 PROBE FOR CALIBRATION (for L and R ARM)





1172-75 SHOCK-ABSORBING SINGLE NEEDLE PROBE (HP)

1172-76 SHOCK-ABSORBING SINGLE NEEDLE PROBE (HP)
1172-76 SHOCK-ABSORBING SINGLE NEEDLE PROBE (HP SR10)
1172-77 SHOCK-ABSORBING SINGLE NEEDLE PROBE (WC SR10)
1172-80 PROBE (Flat spring,3mm stroke)
1172-81 LINK PROBE (Link, high-speed version)
1172-83 DOUBLE LINK PROBE (Double link,35µm between terminals)
1134-02 IMPRESSION SHEFTS

1134-02 IMPRESSION SHEETS 1164-02 ONE-WAY CLUTCH

1164-03 PROBE ATTACHMENT 1196 RECORDING PAPER (25m,10rolls)

1350 OFFSET BOARD (t=2mm) 1350-01 OFFSET BOARD (t=1mm)

## HIOKI E. E. CORPORATION

HEAD OFFICE: 81 Koizumi, Ueda, Nagano, 386-1192, Japan TEL.+81-268-28-0562 / FAX +81-268-28-0568 E-mail: os-com@hioki.co.jp

HIOKI USA CORPORATION:
6 Corporate Drive, Cranbury, NJ 08512 USA
TEL+1-609-409-9109 / FAX +1-609-409-9108
E-mail: hioki@hiokiusa.com

TKK HIOKI CO.,LTD: NO.66-8,Sec.2,Nan Kan Road,Lu-chu, Taoyuan, laiwan TEL +886-3-311-7260 / FAX +886-3-311-8236

HIKING TECHNOLOGY CO.,LTD: 81,Su Hong Xi Road,Suzhou Industrial Park,Suzhou,P.R.CHINA TEL+86-512-62560393 / FAX+86-512-62560390

# HIOKI E.E.CORPORATION Singapore Representative Office: 12 New Industrial Road, #02-04 Thoren Technocentre, Singapore 536202 TEL +65-6288-0050 / FAX +65-6282-2283 E-mail: Info®hioki par.sg

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